

## Fragmentation of Chalcogen Microclusters

K. Nagaya, T. Hayakawa\*, and M. Yao

Department Physics, Graduate School of Science, Kyoto University, 606-01 Kyoto, Japan

### ABSTRACT

S, Se and Te microclusters were produced in free space by a supersonic jet expansion method. The neutral cluster beam were ionized by electron impact and analyzed by a Wiley-McLaren type Time-of-Flight mass spectrometer. The mass spectrum near the appearance potential revealed that  $S_8$  is dominant species in the sulfur cluster beam, and  $Se_5$  is dominant in the selenium cluster beam. As the electron impact energy ( $E_e$ ) increases, the relative intensity of small clusters increases due to fragmentation. The  $E_e$  dependence of the relative intensities may suggest that the neutral dimers are emitted from the clusters in the fragmentation process. In the case of selenium cluster, other process such as evaporation of dimer ion should be considered in addition to the evaporation of neutral dimer.

### 1. INTRODUCTION

Much efforts have been devoted to study the fragmentation process of the covalently bonded clusters such as C[1-5], Si[6-7] and Ge[7]. In these clusters, the small clusters are evaporated in dominant fragmentation pathway. For example, the fragmentation of  $C_n^+$  clusters is dominated by loss of neutral  $C_3$  when  $n < 30$ , while for large carbon clusters the dominant fragmentation process is loss of neutral dimer.

For chalcogen clusters, mass spectroscopy[8-14] and photoelectron spectroscopy[15] are done by several authors. However, not much is known about the fragmentation process of chalcogen microclusters, except for tellurium clusters, for which the evaporation of  $Te_2^+$ ,  $Te_5^+$  and  $Te_4$  is dominant in the fragmentation process.[16]

In the present study, we have produced chalcogen microclusters by means of supersonic expansion method, and carried out mass spectroscopic measurements as a function of an electron impact energy. From the energy dependence of the relative intensity of cluster, we discuss on the fragmentation process of the sulfur and selenium clusters.

### 2. EXPERIMENTAL PROCEDURE

The experimental apparatus consists of an expansion chamber and an analyzing chamber. The former was evacuated with pumping speed of 1200l/s and the latter with 400l/s. A cluster source was made of a quartz glass tube. The glass tube had a converging nozzle with about 0.1 mm in diameter at the end, and a sample reservoir was connected to the middle part of the glass tube. We used S with 99.999%, Se with 99.999% and Te with 99.999% purity as starting materials and Ar gas with 99.99% purity as carrier gas whose pressure was controlled at about 10 torr. A conical skimmer with an aperture of 2 mm was located at about 10 mm apart from the nozzle. We used a Wiley-McLaren type time-of-flight mass spectrometer [17], for which the clusters were ionized by electron impact. Further details of experimental procedure are described elsewhere.[18-19]

### 3. RESULT

Figure 1 shows the mass spectrum for S, Se and Te clusters ionized with an electron energy  $E_e$  of 16 eV. The mass spectrum shown in Fig. 1 were taken

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\* JSPS Reseach Fellow

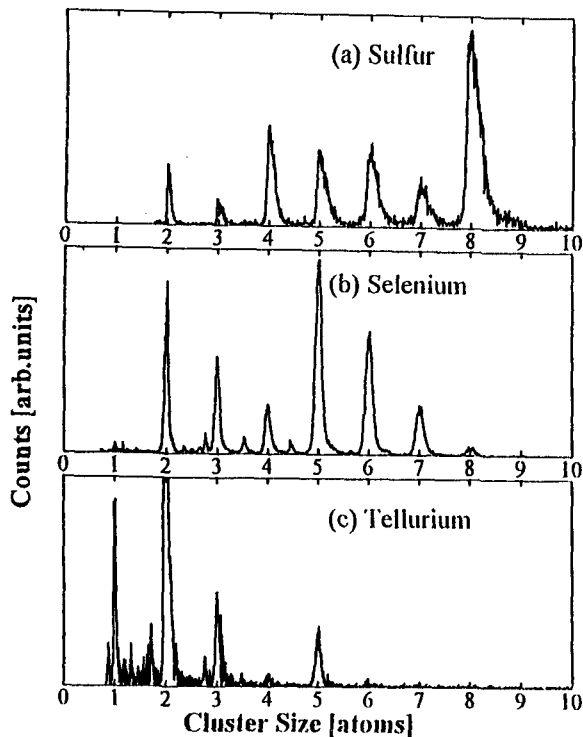


Fig.1 Mass spectrum of chalcogen clusters ionized with an electron energy of 16eV. (a) Sulfur clusters. The nozzle temperature is 200°C (b) Selenium clusters. The nozzle temperature is 400°C. (c) Tellurium clusters. The nozzle temperature is 500°C.

under condition that nozzle temperature was 200°C for S, 400°C for Se and 500°C for Te. Positively charged clusters,  $X_n^+$  ( $X=S, Se, Te$ ), are seen up to  $n=8$  for S and Se, up to  $n=6$  for Te.

We varied the electron impact energy  $E_e$  with keeping the expansion condition as in Fig.1. In S cluster,  $S_8^+$  is dominant near the threshold energy. As  $E_e$  increases, the abundance of  $S_8^+$  is substantially reduced, and that of smaller species increases. In Se cluster, dominant species is  $Se_5^+$  near the threshold, but similar trend is observed when  $E_e$  is increased.

In Figure 2, the relative intensity of  $S_n^+$  clusters,  $I(S_n^+)$ , of even membered clusters and the sum of  $I(S_n^+)$  of even membered clusters, are plotted as a function of  $E_e$ . Here  $I(S_n^+)$  is normalized as

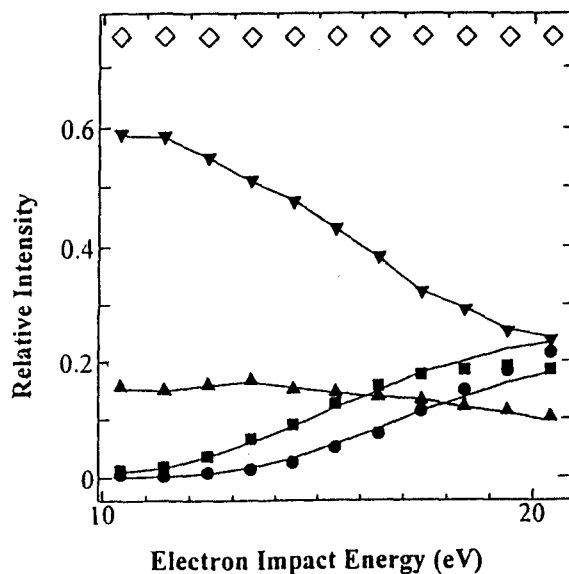


Fig.2 Relative intensities of even membered  $S_n^+$  are plotted as a function of electron energy. Expansion condition is same as Fig. 1(a). ● :  $n=2$ , ■ :  $n=4$ , ▲ :  $n=6$ , ▼ :  $n=8$ , ◇ : sum of even membered clusters. Lines denote the results of fitting. (see text)

$$\sum_{n=1}^8 I(S_n^+) = 1. \quad (1)$$

The present  $I(S_n^+)$  data agree qualitatively with the previous data by Arnold et al.[11].  $I(S_8^+)$  and  $I(S_7^+)$  are high at low  $E_e$  and decrease rapidly with increasing  $E_e$ .  $I(S_6^+)$  and  $I(S_5^+)$  increase with  $E_e$  and show a maximum around 15 eV, where the intensity of smaller clusters starts to rise. It should be noticed that the sum of  $I(S_n^+)$  of even membered clusters is nearly preserved when  $E_e$  is changed.

The relative intensity of  $Se_n^+$  clusters,  $I(Se_n^+)$ , are shown as a function of  $E_e$  in Fig. 3. In the present experiment  $I(Se_n^+)$  shows the following trend at low  $E_e$  (around 10eV):

$$I(Se_5^+) > I(Se_6^+) > I(Se_7^+) \geq I(Se_2^+). \quad (2)$$

This result is in good agreement with the result by Becker et al.[15], who measured the mass spectrum with keeping the cluster source at 520°C. On the other hand, Tribollet et al.[10] and other authors

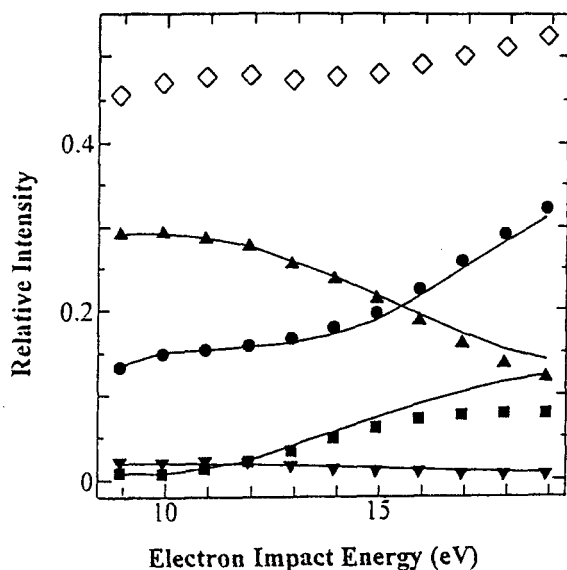


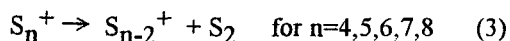
Fig.3 Relative intensities of even membered  $Se_n^+$  are plotted as a function of electron energy. Expansion condition is same as Fig. 1(b). ● :  $n=2$ , ■ :  $n=4$ , ▲ :  $n=6$ , ▼ :  $n=8$ , ◇ : sum of even membered clusters. Lines denote the results of fitting. (see text)

[13], who kept the vapor temperature around 220°C, reported that  $I(Se_5^+) < I(Se_6^+)$ .

The observed  $E_e$  dependence of  $I(Se_n^+)$  is similar to that of  $I(S_n^+)$ , but the sum of  $I(Se_n^+)$  of even membered clusters start to increase around 15eV.

#### 4.DISCUSSION

From the energy dependence of the relative intensities shown in Fig.2, we suggest the following fragmentation processes:



These processes involve evaporation of neutral dimer  $S_2$  rather than fission, though the escaping neutral species cannot be detected directly by the mass spectroscopy. The evaporation of stable neutral species is also observed as dominant processes in other covalently bonded clusters such as carbon [1-5].

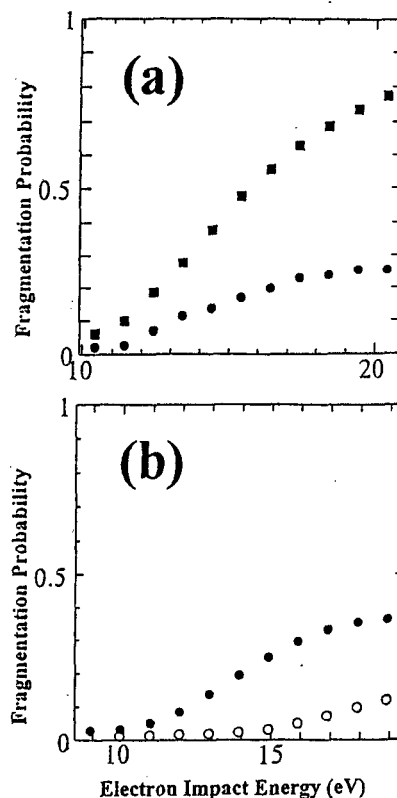


Fig.4 Fragmentation probability of the  $S_n^+$  and  $Se_n^+$ . (a) Sulfur cluster. ● :  $p$ , ■ :  $q$ .  $p$  represents the fragmentation probability of  $S_8^+$ , and  $q$  is fragmentation probability of  $S_4^+$  and  $S_6^+$ . (b) Selenium cluster. ● :  $p$ , ○ :  $r$ .  $Se_2$  emitted with the probability  $p$ , and  $Se_2^+$  emitted with the probability  $r$ .

In order to describe the fragmentation processes quantitatively, we first tried to fit the observed  $I(S_n^+)$  with the simplest model that all even (or odd) membered clusters emits the dimer with the same evaporation probability. However, this model did not reproduce the observed  $I(S_n^+)$  of even membered clusters. Then we modified this model, assuming that the fragmentation probability of  $S_8^+$ ,  $p$ , is smaller than that of the  $S_6^+$  and  $S_4^+$  clusters,  $q$ , because the  $S_8^+$  cluster is thought to be more stable. This assumption improves the fitting remarkably. In Fig.2 the results of this fitting denoted by lines. The probabilities  $p$  and  $q$  deduced from this model are plotted as a function of  $E_e$  in

Fig.4(a). At low  $E_e$   $p$  and  $q$  start to rise near the ionization potential and at higher  $E_e$  seem to become saturated. This may suggest that S cluster could be thermally excited by excess electron energy (i.e. difference between  $E_e$  and the ionization potential) during the ionization process, and that the fragmentation should follow the Arrhenius' equation of chemical kinetics.

For Se cluster, we also tried to fit the observed  $I(\text{Se}_n^+)$  with the simplest model that all even (or odd) membered clusters have the same evaporation probability. The calculated  $I(\text{Se}_n^+)$  agrees with the observed  $I(\text{Se}_n^+)$  at lower  $E_e$ . However, the agreement become poor when  $E_e$  increases. This is because the sum of  $I(\text{Se}_n^+)$  of even membered cluster is no more preserved above 15eV. So we should take into account another fragmentation process in which odd membered clusters are converted into even membered clusters. The evaporation of dimer ion is one of the simplest process to achieve such conversion. Assuming that the probability of neutral dimer evaporation is  $p$  and that of evaporation of dimer ion is  $r$ , we have calculated  $I(\text{Se}_n^+)$  and shown them by the lines in Fig.3. The calculated  $I(\text{Se}_n^+)$  reproduce well the experimental values, up to 20eV. We also examined other models, such that neutral trimer would be evaporated from the clusters instead of charged dimer, but they could not explain the observed  $I(\text{Se}_n^+)$ .

## 5.SUMMARY

We have measured the mass spectrum for S, Se clusters. The dependence of  $I(\text{S}_n^+)$  on the electron impact energy  $E_e$  suggests that neutral  $\text{S}_2$  dimer may be evaporated from  $\text{S}_n^+$  clusters. The  $E_e$  dependence of  $I(\text{Se}_n^+)$  suggest that other evaporation process such as the dimer ion evaporation should be considered in addition to the evaporation of neutral dimer.

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